

### FRAUNHOFER INSTITUTE FOR MICROELECTRONIC CIRCUITS AND SYSTEMS IMS



1 Eval-Kit camera system.

2 Wafer carrying linear sensors.

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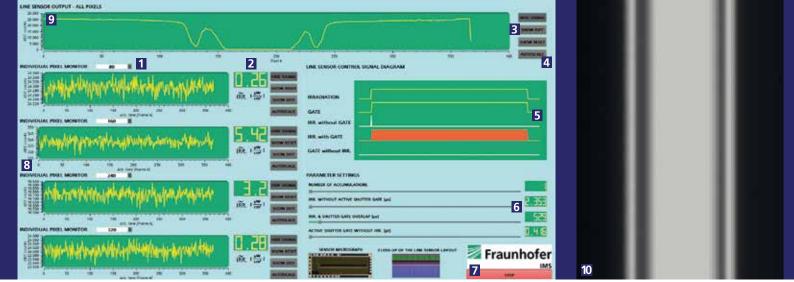
# **EVALUATION KIT FOR LINEAR SPECTROSCOPY SENSORS**

Our new EvalKit for linear spectroscopy sensors supports product managers and R&D departments in their development tasks. You will have a complete spectroscopy camera system, which enables testing the functionality and performance of our linear sensors. Adjustments to customer's applications are possible within a wide range of flexibility.

The EvalKit for the spectroscopy line sensor is used for raw data image acquisition in time-gated measurements. The designed detector exhibits a very high sensitivity in a broad spectral range, starting from the UV up to the NIR, as it is required in dedicated applications. The photogenerated charge is accumulated over several programmable measurement cycles without the need of resetting, thanks to the very low dark current profile of the linear sensors. In our sensor family, a high dynamic range and pulse gated image acquisition has been realized along with the non-destructive readout and in-pixel accumulation possibilities. This makes the EvalKit for spectroscopy line sensors an ideal candidate for optical emission spectroscopy applications.

With the EvalKit software it is possible to display raw line sensor pixel signals, as well as corrected signals utilizing digital double sampling. The analog to digital conversion is performed by a high performance 16bit 10MHz A/D converter, enabling noise measurements for sensor characterization. The image output is available in spatial representation of the integrated, 368 spectroscopy pixel line with an option to display additional waveforms of 4 arbitrary pixel signals. In addition, a FIFO based waterfall like visualization of the sensor pixel signals with a memory of the last 50 lineframes is also available in the software.

By employing the acquisition control signals represented by different sliders in the EvalKit GUI, a user has an option to realize a large variety of pulse illuminated measurements, which are capable of capturing the pulse shape of the illumination source for calibration and / or measurement purposes. Moreover, the effective dynamic range of the sensor can be adapted to the illumination conditions by adjusting the number of accumulations.



### **EvalKit Specifications**

### **Evaluation Kit**

Supply voltage Power consumption Lens Board dimensions Operating temperature Standard accessory Sensor Line rate Data format Interface Illumination gate signal Configuration software System requirements Operating manual

### **CMOS Spectroscopy linear sensor**

Spatial resolution Pixel pitch/size Conversion gain Spectral range Responsivity @ 525 nm Quantum efficiency @ 525 nm Linearity Saturation capacity Sense node capacitance Signal-to-noise ratio Dynamic range Read noise DSNU1288 **PRNU1288** Electrical crosstalk Dark signal (T  $\approx$  22 °C) Process

12 V/1 A via wall power supply 3 W Standard C-Mount 1/3" (not included) 98.9 mm × 53 mm -20 °C up to + 60 °C USB driver FTDS, Visualization 368 × 1 Pixel CMOS LDPD 25 Hz 16 bit / 100 kHz USB 2.0 (Raw sensor data, configuration and control) LV CMOS 3.3 V output Arduino, openCV, Qt Windows 7 PC Included (development source upon customer request)

368 × 1 10 µm \* 200 µm 17 µV/e<sup>-</sup> 250 nm up to 1000 nm 530 V/(µJ/cm<sup>2</sup>) 60 % 0.5 % 59 ke-7.50 fF 47 dB 63 dB 38 e<sup>-</sup> 7.5 mV 1.6% < 4 % 75 mV/s 0.35 µm CMOS + LDPD + UV-Transparent Passivation

